

**Search Notes**

Application/Control No.

10/690,743

Examiner

Leonardo Andújar

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

2826

**SEARCHED**

Class	Subclass	Date	Examiner
257	685, 686 712, 713 720	3/15/2005	LA

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	3/15/2005	LA